Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10575347	KIM ET AL.
Examiner	Art Unit
Jennifer F Chang	4158

SEARCHED					
Class		Subclass	Date	Examiner	
343	702		11/14/2007	Jennifer F.	
				Chang	

SEARCH NOTES				
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EAST Search History	11/14/2007	Jennifer F. Chang		
Inventor Search in eDAN	11/14/2007	Jennifer F. Chang		

INTERFERENCE SEARCH			
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